

Application/Control No.	Applicant(s)/Patent under Reexamination
10/667,321	OMORI ET AL.
Examiner	Art Unit
Hai C. Pham	2861

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	234-237, 247-252	3/18/2005	НĖ
327	2-3, 136	3/18/2005	НР
	141-149		
	158		
358	474	3/18/2005	НР
[			

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
347	249	3/18/2005	НР			
	<u> </u>					

(INCLUDING SEA	DATE	EXMR
EAST TEXT SEARCH	3/18/2005	НР
		=